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Published in:
The 24th International Congress on Glass - Abstracts

Publication date:
2016

Document Version
Publisher's PDF, also known as Version of record

Link to publication from Aalborg University

Citation for published version (APA):
Chemical fluctuation and phase transition in amorphous micro silica

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Amorphous micro silica (MS) has been widely applied in various industries, e.g., in cement and calcium silicate production. Porous calcium silicate is an excellent insulation material, especially in high temperature environment. Besides lime, MS is the second key component for producing porous calcium silicate. Recently we have found that the quality, characteristics and source of MS has a strong impact on the performances of the final products. To understand the mechanism of such impact and to improve the properties of final product, it is crucial to identify the difference in morphology, phase transition, impurity among MS materials that originate from different sources and/or are produced using different methods. In this study, we investigate three types of MS materials with different impurities, which were obtained from three producers. Two of the MS are by-products from the silicon production (MS1 and MS2) and the third is a by-product from the ferro silicon production (MS3). Their chemical compositions (wt%) were analysed by means of X-ray fluorescence (XRF) (see Table 1).

<table>
<thead>
<tr>
<th>Sample</th>
<th>SiO₂</th>
<th>MgO</th>
<th>Na₂O</th>
<th>Fe₂O₃</th>
<th>T_exo(°C)</th>
<th>T_end(°C)</th>
</tr>
</thead>
<tbody>
<tr>
<td>MS1</td>
<td>95.9</td>
<td>0.3</td>
<td>0.04</td>
<td>0.08</td>
<td>1107</td>
<td>226</td>
</tr>
<tr>
<td>MS2</td>
<td>96.1</td>
<td>0.2</td>
<td>0.50</td>
<td>0.70</td>
<td>1104</td>
<td>238</td>
</tr>
<tr>
<td>MS3</td>
<td>92.1</td>
<td>1.2</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

Through differential scanning calorimetry (DSC) we have identified striking differences of phase transition behavior among the three samples. During the first upscan, the exothermic response peak of MS2 occurs at a much higher temperature (T_exo) compared to MS1 and MS3 and °C (Fig. 1 and Table 1). These peaks are attributed to the cristobalite formation. This can be confirmed by the second upscan curves showing the endothermic peaks in the temperature region of T_end=226–248°C (Inset of Fig. 1 and Table 1), i.e., the temperature region of the α- to β-cristobalite transition. The crystal structure of MS is identified using X-ray diffraction (XRD) on both the as-received (Fig. 2), and the heat-treated samples at their respective T_ks for 3 hours (Inset of Fig. 2).

The as-received silica contains mainly amorphous phase with a trace of quartz. MS3 has a slightly higher degree of crystallinity than MS1 and MS2, indicating that MS3 has a higher content of impurities as nucleating agents. MS1 exhibits higher content of cristobalite than MS2. All the heat-treated samples display cristobalite, but MS3 also exhibits traces of other crystalline phases.

The higher T_exo of MS2 indicates the presence of fewer crystallites in MS2 compared to MS1 and MS3. The XRD spectra indicate that a trace of cristobalite is already present in the as-received MS1 and MS3 samples, and acts as nucleating agent resulting in lower T_exo. MS3 has a higher content of impurity, especially higher Na and Fe contents in than MS1 and MS2. The devitrification of amorphous micro silica is strongly enhanced by its impurities, especially alkali metals. Micro silica originated from different production sources exhibits different morphology and structure, and hence could affect the properties of calcium silicate products. This is being closely investigated in a separated work.

This work indicates that the detection of crystallization from DSC scans could be used as a standard method to monitor the fluctuation of the impurities of amorphous micro silica.